

DS26LV32AQML 3V Enhanced CMOS Quad Differential Line Receiver

Check for Samples: [DS26LV32AQML](#)

FEATURES

- Comparable to Both TIA/EIA-422 and ITU-T V.11 Standards
- Low Power CMOS Design (30 mW typical)
- Interoperable with Existing 5V RS-422 Networks
- Receiver OPEN Input Failsafe Feature
- Pin Compatible with DS26C32AT

DESCRIPTION

The DS26LV32A is a high speed quad differential CMOS receiver that is comparable to TIA/EIA-422-B and ITU-T V.11 standards, but with a specified common mode voltage range of -0.5V to +5.5V due to the lower operating supply voltage of 3.0V to 3.6V. The TRI-STATE enables, EN and $\overline{\text{EN}}$, allow the device to be active High or active Low. The enables are common to all four receivers. The receiver output (RO) is specified to be High when the inputs are left open. The receiver can detect signals as low as $\pm 200\text{mV}$ over the common mode range of -0.5V to +5.5V. The receiver outputs (RO) are compatible with TTL and LVCMOS levels.

Connection Diagram

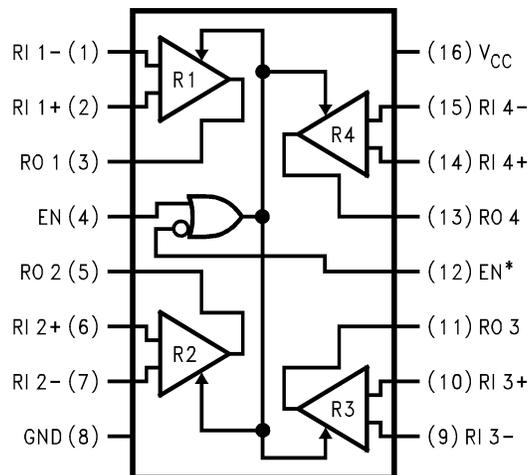


Figure 1. CLGA Package- Top View
See Package Number NAD0016A



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings⁽¹⁾

Supply Voltage (V_{CC})	7.0V
Common Mode Range (V_{CM})	$\pm 14V$
Differential Input Voltage (V_{Diff})	$\pm 14V$
Enable Input Voltage (V_I)	-0.5V to $V_{CC}+0.5V$
Storage Temperature Range (T_{Stg})	$-65^{\circ}C \leq T_A \leq +150^{\circ}C$
Lead Temperature (T_L) Soldering, 4 seconds	260°C
Maximum Power Dissipation +25°C ⁽²⁾	1087mW
Thermal Resistance	
θ_{JA}	138°C/W
θ_{JC}	13.5°C/W

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not verify specific performance limits. For verified specifications and test conditions, see the Electrical Characteristics. The verified specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) Derate CERPAK 7.3mW/°C above +25°C.

Recommended Operating Conditions

Supply Voltage (v_{CC})	3.0V to 3.6V
Operating Temperature Range (T_A)	$-55^{\circ}C \leq T_A \leq +125^{\circ}C$

Table 1. Quality Conformance Inspection Mil-Std-883, Method 5005 - Group A

Subgroup	Description	Temp °C
1	Static tests at	25
2	Static tests at	125
3	Static tests at	-55
4	Dynamic tests at	25
5	Dynamic tests at	125
6	Dynamic tests at	-55
7	Functional tests at	25
8A	Functional tests at	125
8B	Functional tests at	-55
9	Switching tests at	25
10	Switching tests at	125
11	Switching tests at	-55
12	Settling time at	25
13	Settling time at	125
14	Settling time at	-55

DS26LV32AQL Electrical Characteristics DC Parameters

Parameter		Test Conditions	Notes	Min	Max	Units	Sub-groups
V _{Th}	Minimum Differential Input Voltage	V _{CC} = 3.0/3.6V, V _O = V _{OH} or V _{OL} , -0.5V < V _{CM} < +5.5V		-200	+200	mV	1, 2, 3
R _I	Input Resistance	V _{CC} = 3.6V, -0.5V < V _{CM} < +5.5V, One input AC Gnd		5.0		KΩ	1, 2, 3
I _I	Input Current	V _{CC} = 3.6V, V _I = +5.5V Other Input = Gnd		0.0	+1.8	mA	1, 2, 3
		V _{CC} = 3.6V, V _I = -0.5V Other Input = Gnd		0.0	-1.8	mA	1, 2, 3
		V _{CC} = 0V, V _I = +5.5V Other Input = Gnd		0.0	+1.8	mA	1, 2, 3
		V _{CC} = 0V, V _I = -0.5V Other Input = Gnd		0.0	-1.8	mA	1, 2, 3
V _{OH}	Logical "1" Output Voltage	V _{CC} = 3.0V, V _{Diff} = +1V, I _O = -6.0mA		2.4		V	1, 2, 3
V _{OL}	Logical "0" Output Voltage	V _{CC} = 3.0V, V _{Diff} = -1V, I _O = 6.0mA			0.5	V	1, 2, 3
V _{IH}	Minimum Enable High Level Voltage		(1)	2.0		V	1, 2, 3
V _{IL}	Maximum Enable Low Level Voltage		(1)		0.8	V	1, 2, 3
I _{OZ}	Maximum TRI-STATE Output Leakage Current	V _{CC} = 3.6V, V _O = V _{CC} or Gnd Enable = V _{IL} , Enable = V _{IH}			±50	μA	1, 2, 3
I _{En}	Maximum Enable Input Current	V _{CC} = 3.6V, V _I = V _{CC} or Gnd			±1.0	μA	1, 2, 3
I _{CC}	Quiescent Power Supply Current	V _{CC} = 3.6V, No Load, En, En = V _{CC} or Gnd, -0.5V < V _{CM} < +5.5V			20	mA	1, 2, 3
I _{OS}	Output Short Circuit Current	V _{CC} = 3.0V/3.6V, V _O = 0V, V _{Diff} = +1V	(2)	-10	-70	mA	1, 2, 3

(1) Parameter tested Go-No-Go only.

(2) Short one output at a time to Gnd.

DS26LV32AQL Electrical Characteristics AC Parameters

The following conditions apply, unless otherwise specified.

AC: V_{CC} = 3.0/3.6V, C_L = 50pF

Parameter		Test Conditions	Notes	Min	Max	Units	Sub-groups
t _{PLH}	Input to Output Propagation Delay	V _{CM} = 1.5V	(1)	6.0	45	nS	9, 10, 11
t _{PHL}	Input to Output Propagation Delay	V _{CM} = 1.5V	(1)	6.0	45	nS	9, 10, 11
t _{SK1}	Skew tpHLD-tpLHD (same channel)				6.0	nS	9, 10, 11
t _{SK2}	Pin to Pin Skew (Same device)				6.0	nS	9, 10, 11
t _{PLZ}	Output Disable Time	2KΩ to V _{CC}	(2)		50	nS	9, 10, 11
t _{PZL}	Output Enable Time	2KΩ to V _{CC}	(2)		50	nS	9, 10, 11
t _{PHZ}	Output Disable Time	2KΩ to Gnd	(2)		50	nS	9, 10, 11
t _{PZH}	Output Enable Time	2KΩ to Gnd	(2)		50	nS	9, 10, 11

(1) Generator waveform is specified as follows: f = 1MHz, Duty Cycle = 50%, Z_O = 50Ω, t_R = t_F ≤ 6nS. Receiver inputs = 1V to 2V with measure points equal to 1.5V on the inputs to 1/2 V_{CC} on the outputs.

(2) Generator waveform is specified as follows: f = 1MHz, Duty Cycle = 50%, Z_O = 50Ω, t_R = t_F ≤ 6nS. En/ $\overline{\text{En}}$ inputs = 0V to 3V with measure points equal to 1.5V on the inputs, to 1/2 V_{CC} on the outputs for Z_L and Z_H, and (V_{OL} + 0.3V) for L_Z, and (V_{OH} - 0.3V) for H_Z.

REVISION HISTORY

Released	Revision	Section	Originator	Changes
3/01/06	*	New Release, Corporate format	L. Lytle	1 MDS data sheet converted into one Corp. data sheet format. MNDS26LV32A-X Rev 0A0 will be archived.
4/15/2013	A		TIS	Changed layout of National Data Sheet to TI format

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
5962-9858501QFA	ACTIVE	CFP	NAD	16	19	TBD	Call TI	Call TI	-55 to 125	DS26LV32AW-QML Q 5962-98585 01QFA ACO 01QFA >T	Samples
DS26LV32AW-QML	ACTIVE	CFP	NAD	16	19	TBD	Call TI	Call TI	-55 to 125	DS26LV32AW-QML Q 5962-98585 01QFA ACO 01QFA >T	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

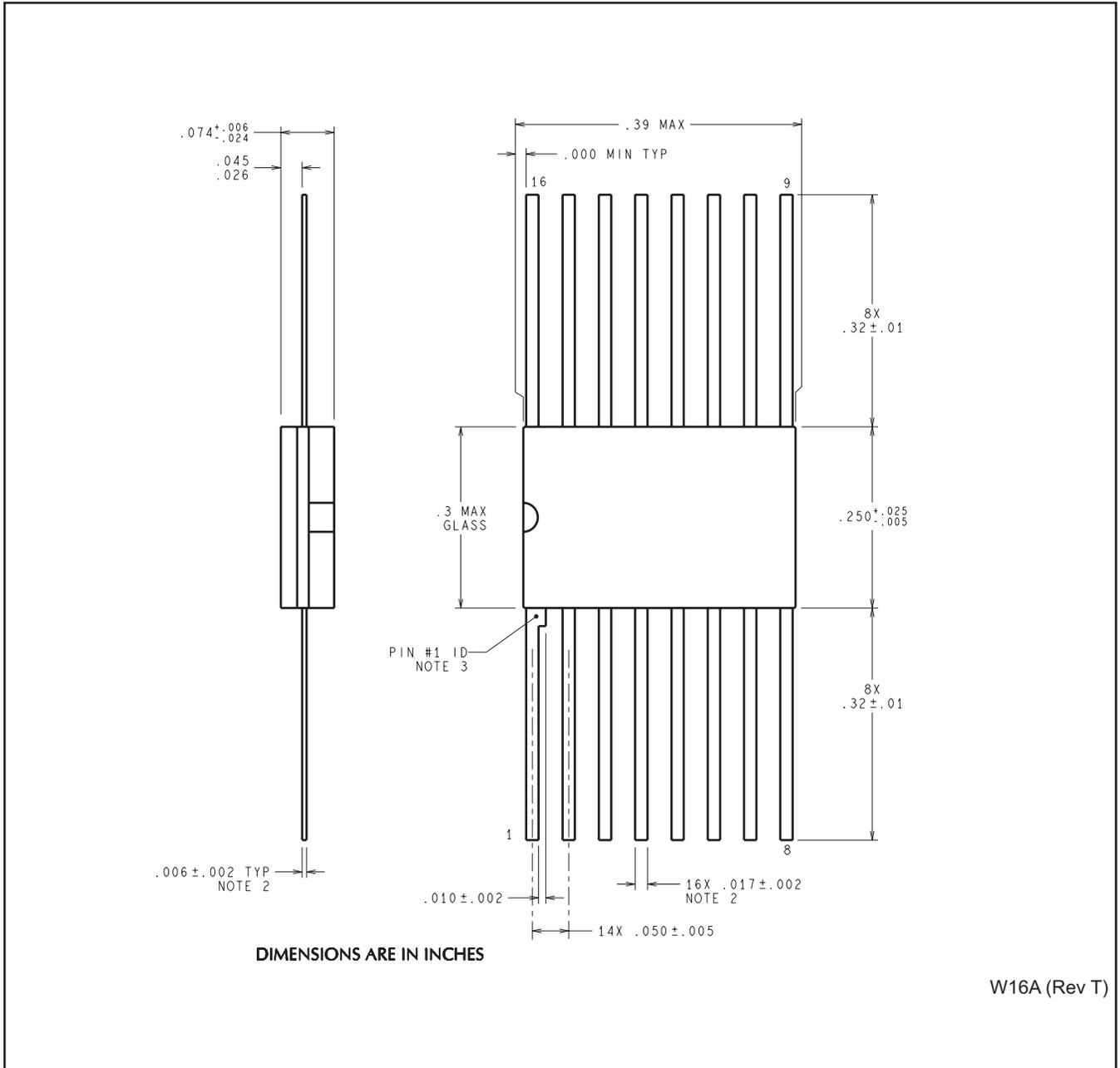
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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